

NOTICE

WAFER BREAKAGE HAZARD

Vacuum Bagging May Cause

Wafer Breakage

Do Not Vacuum Bag Shipper

TEST

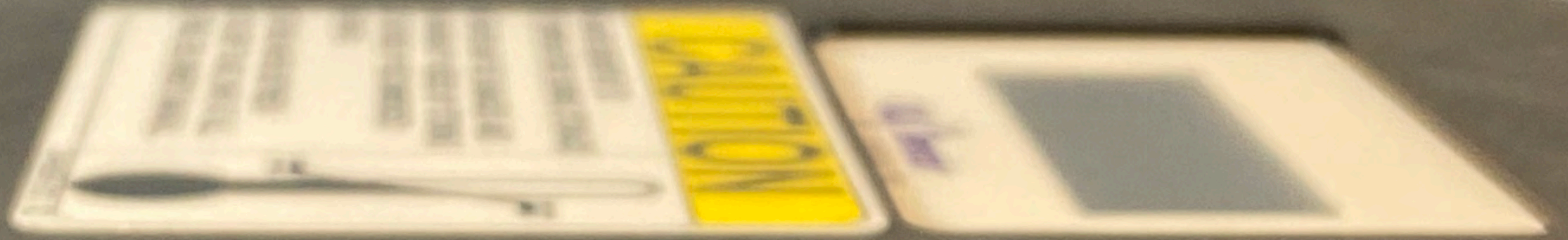


CAUTION
WAFER RESISTIVE TEMPERATURE COEFFICIENT (TRC) IS SENSITIVE TO TEMPERATURE. WAFERS MAY BE DAMAGED AND IMPURITY LEVELS OF TRENCH CUTTING BY REWORKING RANGE. STORE WAFERS IN THE AS SUPPLIED CONDITION. THIS IS THE ONLY WAY TO



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**DIAGNOSTIC
PORT**

